

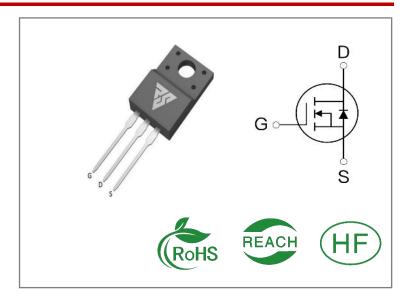
ID	R _{DS} (ON)(Typ)	VDSS
10A	0.6Ω	600V

Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Features:

- Fast switching speed
- 100% avalanche tested
- Improved dv/dt capability



Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS10N60F	T0-220F	RS10N60F	Tube	50 PCS

Absolute Maximun Ratings Tc= 25°C unless otherwise specified

Symbol	Parameter	RS10N60F	Units
VDSS	Drain-to-Source Voltage	600	V
ID	Continuous Drain Current TC=25℃	10	Δ.
IDM	Pulsed Drain Current (Note*1)	40	А
PD	Power Dissipation	39	W
VGS	Gate- to- Source Voltage	±30	V
EAS	Single Pulse Avalanche Engergy L = 10mH, VDD = 50V, RG = 25 Ω	302	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	$^{\circ}$
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

^{*} Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS10N60F	Units	Test Conditions
RθJC	Junction-to-Case	3.2	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^{\circ}\mathrm{C}$
RθJA	Junction-to- Ambient	62.5		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25℃ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	600			V	VGS=0V,ID=250μ A
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=600V,VGS= 0V
IGSS	Gate- to- Source Forward Leakage			100	- A	VGS=30V ,VDS=0 V
1033	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS= 0V

ON Characteristics TJ=25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		0.6	0.72	Ω	VGS=10V,ID=5A
VGS(TH	Gate Threshold Voltage	3		4	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		12			
trise	Rise Time		130			VDS=300V
td(OFF)	Turn- OFF Delay Time		80		nS	ID=10A RG=25Ω
tfall	Fall Time		20			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1420			VGS=0V
Coss	Output Capacitance		157		pF	VDS=25V
Crss	Reverse Transfer Capacitance		20			f=1.0MHz
Qg	Total Gate Charge		42			VDS=400V
Qgs	Gate- to- Source Charge		6		nC	ID=10A
Qgd	Gate-to-Drain(" Miller") Charge		22			VGS=10V

Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			10	Α	Integral pn- diode
ISM	Maximum Pulsed Current			40	Α	in MOSFET
VSD	Diode Forward Voltage			1.4	V	IS=5A,VGS=0V
trr	Reverse Recovery Time		320		nS	VGS=0V
Qrr	Reverse Recovery Charge		3.4		μC	IS=10A,di/dt=100 A/μs

Notes:

^{* 1.} Repetitive rating, pulse width limited by maximum junction temperature.

^{* 2.} Pulse Test: Pulse width ≤ 300μs, Duty Cycle ≤ 1%



Typical Feature Curve

Figure 1 Output Characteristics (T = 25%

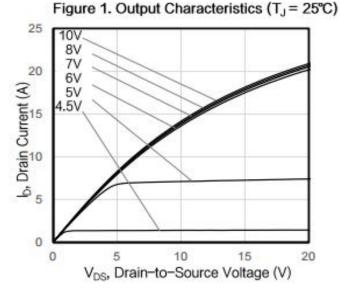


Figure 3. Drain Current vs. Temperature

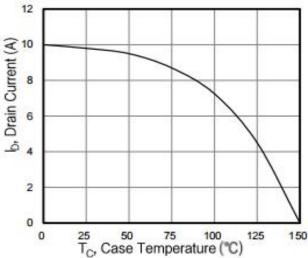


Figure 5. Transfer Characteristics

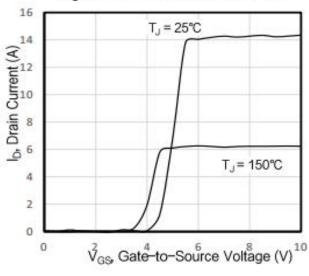


Figure 2. Body Diode Forward Voltage

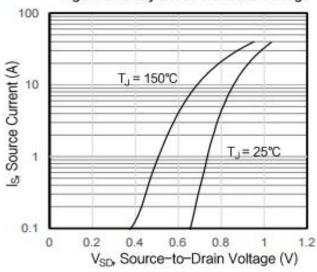


Figure 4. BV_{DSS} Variation vs. Temperature

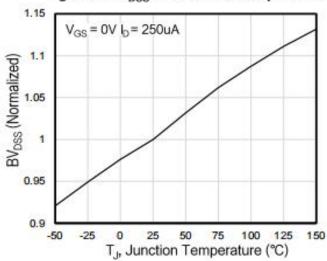
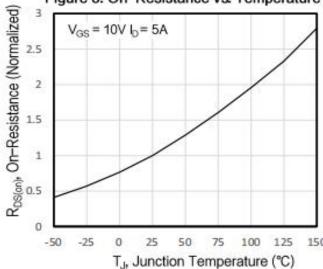
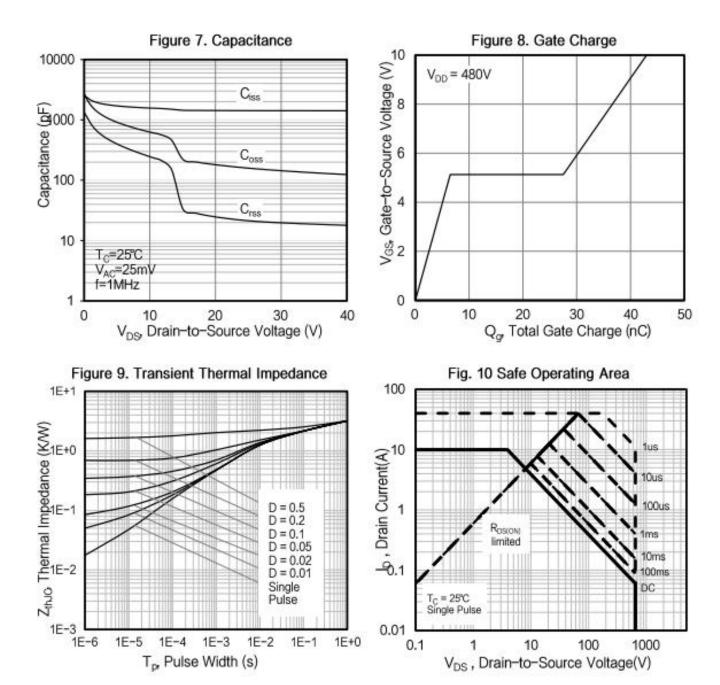


Figure 6. On-Resistance vs. Temperature



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Test Circuits and Waveforms

Figure A: Gate Charge Test Circuit and Waveform

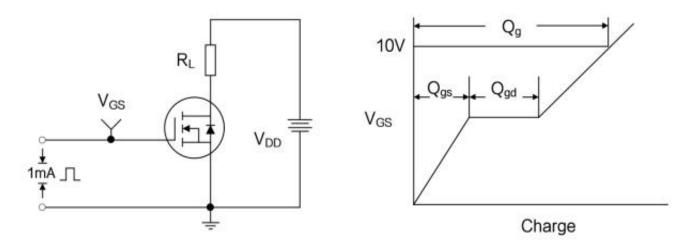


Figure B: Resistive Switching Test Circuit and Waveform

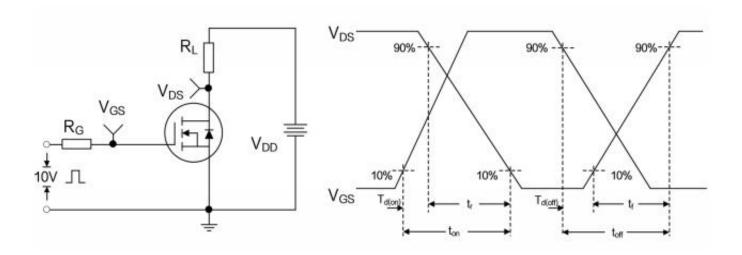
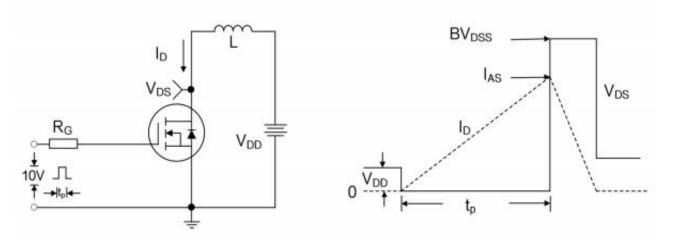


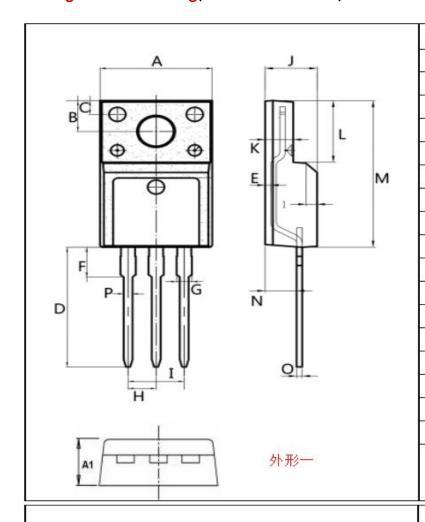
Figure C: Unclamped Inductive Switching Test Circuit and Waveform



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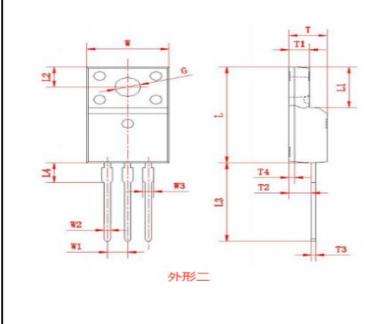


Package outline drawing(TO-220F Unit: mm)



Dim.	Min.	Max.
Α	9.95	10.36
A1	4.5	5.0
В	2.95	3.25
С	1.25	1.45
D	12.60	13.60
E	0.40	0.60
F	2.8	3.5
G	1.30	1.45
Н	(2.54	1)
1	(5.08	3)
J	4.60	4.75
K	2.45	2.65
L	6.5	6.8
М	15.4	16.0
N	2.25	3.05
0	0.45	0.55
Р	0.70	0.90

All Dimensions in millimeter



Dim.	Min.	Max.		
W	9.95	10.36		
W1	(2.54)			
W2	0.70	0.90		
W3	1.25	1.47		
L	15.67	16.07		
L1	6.48	6.88		
L2	3.2	3.4		
L3	12.6	13.6		
L4	(3.23)			
Т	4.50	4.90		
T1	2.34	2.74		
T2	2.25	2.95		
T3	0.45	0.60		
T4	(0.	70)		
G	3.08	3.28		



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